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STANDARDIZED MILITARY DRAWING  THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS				APE	PROVI	OA ED B	ROV	AL 6		00	<u></u>	MICROCIRCUITS, LINEAR, LOW-POWER, HIGH PRECISION OPERATIONAL AMPLIFIER, MONOLITHIC SILICON  SIZE CAGE CODE													
DEPART	AND AGENCIES OF TH _ DEPARTMENT OF DEFENSE AMSC N/A			ŀ	15 AUGUST 1989 REVISION LEVEL					-	A 67268 5962-895				<b>35</b> 4	4									

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1. SCOPE		<del></del>			
1.1 Scope. This drawing describes dewith 1.2.1 of MIL-STD-883, "Provisions for non-JAN devices".	vice requi or the use	rement of MI	s for class B L-STD-883 in c	microcircu onjunction	uits in accordance n with compliant
1.2 Part number. The complete part nu	umber shal	1 be a	s shown in the	following	example:
<u>5962-89544</u> <u>01</u>			G		X I
Drawing number Device (1.2	type	,	Case outline (1.2.2)		ad finish per MIL-M-38510
1.2.1 <u>Device type</u> . The device type sh	mall ident	ify th	e circuit func	tion as fo	llows:
<u>Device type</u> <u>Generic nu</u>	mber		Circuit functi	on	
01 OP-97					tional amplifier
1.2.2 <u>Case outlines</u> . The case outline as follows:	s shall be	as d	esignated in a	ppendix C	of MIL-M-38510, and
Outline letter		•	Case outline		
G P	A-1 (8-1 D-4 (8-1	ead, ead,	370" x .185") 405" x .310"	, metal car x .200"),	n package dual-in-line package
1.3 Absolute maximum ratings.		-		•	,
Positive supply voltage (Y+) Negative supply voltage (Y-) Input voltage 1/ Differential input voltage 2/ Differential input current 2/ Maximum power dissipation (PD) 3/ Output short-circuit duration Storage temperature range	60 seconds e (θ <sub>JC</sub> ) - ient (θ <sub>JA</sub> )		20 V dc - ±20 V dc - ±1 V dc - ±10 mA - 500 mW - Indefinite -65 C to - - +300 °C - +150 °C - See MIL-M- - 150 °C/W - 119 °C/W	-150°C -38510, app	pendix C
<ul> <li>1/ For supply voltages less than ±20 V, to voltage.</li> <li>2/ The inputs are protected by back-to-be order to achieve low noise. Different current to flow through the input prot 3/ Derate linearly 7.1 mW/°C above TA = * Derate linearly 6.7 mW/°C above TA = * Must withstand added PD due to short compared to the standard of the short of</li></ul>	ack diodes ial input ection did 80°C for ( 75°C for )	. Cur volta odes u G pack	rent limiting ges greater th nless limiting age.	resistors	are not used in
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## 2. APPLICABLE DOCUMENTS

2.1 Government specification and standard. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

**SPECIFICATION** 

**MILITARY** 

MIL-M-38510 - Microcircuits, General Specification for.

**STANDARD** 

**MILITARY** 

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

## 3. REQUIREMENTS

- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
  - 3.2.1 <u>Terminal connections</u>. The terminal connections shall be as specified on figure 1.
  - 3.2.2 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.
- 3.3 Electrical performance characteristics. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full ambient operating temperature range.
- 3.4 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.
- 3.5 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.6 <u>Certificate of conformance</u>. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-SID-883 (see 3.1 herein).

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	140	LL 1. EIECE	rical perfor	mance chara	ic teristics	•			
Test	Symbol		Conditions	F*0	Group A	Li	mits	Unit	
, , , , , , , , , , , , , , , , , , , ,		-55 V <sub>S</sub> = 4 unless	$C < T_A < +12$ $15 V; R_S = 5$ otherwise sp	5 C OΩ ecified	subgroups	Min	Max		
Input offset voltage	V10				1		   <b>‡</b> 25	<u> </u> μ <b>γ</b>	
· · · · · · · · · · · · · · · · · · ·					2, 3		   ±60		
Input offset voltage temperature coefficient	TCVOS				2, 3	     	0.6	μV/°( 	
Input offset current	I <sub>10</sub>	!			1		<b>±</b> 100	pA	
		! !			2, 3		±250	Ţ	
Input bias current	IIB	! !			1		±100	l pA	
	<u> </u>				2, 3	1	  ±250	Ţ	
Common-mode rejection	CMRR	V <sub>CM</sub> = IVR	= ±13.5 V	<u>1</u> /	1 1	114	 	l dB	
14010	1				2, 3	l   108		T 	
Power supply rejection ratio	I PSRR	V <sub>S</sub> = ±2 V	to ±20 V		1	   114 	] ] [	l dB	
	!   	V <sub>S</sub> = ±2.5	V to ±20 V		2, 3	108	1	T ! !	
Supply current	Is	No load			1		600	ΙμΑ	
		<u> </u>	<del></del>		2, 3		800		
Large-signal voltage gain	Avo	V <sub>O</sub> = ±10 V	, R <sub>L</sub> = 2 kΩ		4	300	<u> </u>	V/mV	
	<u> </u>				5,6	200	<u> </u>	<u> </u>	
Output voltage swing	v <sub>o</sub>	R <sub>L</sub> = 10 kΩ			4, 5, 6	±13	i I	įv	
Slew rate	SR				1 7	0.1		l v	
	] 				   8	0.05		<u>Ι γ</u> Τ μς	
Input noise voltage	E <sub>nt</sub>	0.1 Hz to 1	10 Hz, T <sub>A</sub> = +	25°C	   9 		280	nV <sub>rms</sub>	
Output short circuit	105				1 1	20		l mA	
current					2,3	30	l 	! ]	
losed loop bandwidth	BW [	Aycl = +1, 1	A = +25°C		   4   	0.4	]   	MHz	
/ IVR is defined as	the V <sub>CM</sub>	range used f	or the CMRR	test.	·		·		
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MILITARY DI				DEVICE	N LEVEL		2-89544		
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Device type 01 Case outlines G and P Terminal number Terminal symbols NULL -IN +IN Y-COMP OUT Y+ 12345678 NULL FIGURE 1. Terminal connections STANDAP.DIZED SIZE 5962-89544 Α **MILITARY DRAWING** 

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- 3.8 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
  - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 <u>Screening.</u> Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
  - a. Burn-in test, method 1015 of MIL-STD-883.
    - Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
    - (2)  $T_A = +125^{\circ}C$ , minimum.
  - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
  - 4.3.1 Group A inspection.
    - a. Tests shall be as specified in table II herein.
    - b. Subgroups 10, 11, and 12 in table I, method 5005 of MIL-STD-883 shall be omitted.
  - 4.3.2 Groups C and D inspections.
    - a. End-point electrical parameters shall be as specified in table II herein.
    - b. Steady-state life test conditions, method 1005 of MIL-STD-883.
      - Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
      - (2)  $T_A = +125^{\circ}C$ , minimum.
      - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

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## TABLE II. <u>Electrical</u> test requirements.

	<del> </del>
MIL-STD-883 test requirements	Subgroups     (per method     5005, table I)
Interim electrical parameters (method 5004)	1
   Final electrical test parameters   (method 5004)	1*,2,3,4,5, 6,7,8
Group A test requirements (method 5005)	1,2,3,4,5, 6,7,8,9
   Groups C and D end-point   electrical parameters   (method 5005)	   1**   

- \* PDA applies to subgroup 1, excluding V<sub>IO</sub> end-points. (No other subgroups are included in PDA).
- \*\* In accordance with table 1, except  $V_{IO}$  = ±50  $\mu V$  maximum.
- 5. PACKAGING
- $5.1\,$  Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.
  - 6. NOTES
- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
- 6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- $^{6.3}$  Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone  $^{513-296-5375}$ .

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6.4 Approved source of supply. An approved source of supply is listed herein. Additional sources will be added as they become available. The vendor listed herein has agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing part number	Vendor     CAGE   number	Vendor similar part number <u>1</u> /
5962-8954401GX	06665	OP-97AJ/883
5962-8954401PX	06665	OP-97AZ/883

1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

**Vendor CAGE** number

Vendor name and address

06665

Precision Monolithics Incorporated 1500 Space Park Drive Santa Clara, CA 95052-8020

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